
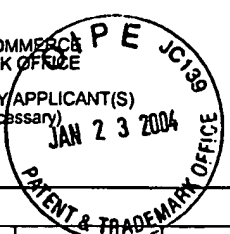




FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>02910.000105</b>		APPLICATION NO. <b>10/726,503</b>	
				APPLICANT <b>TATSUYA NAKAMURA ET AL.</b>			
				FILING DATE <b>D c mber 4, 2003</b>			GROUP <b>Unassigned</b>
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>16</i>		<b>4301335</b>	<b>11/81</b>	<b>Kimbrough et al.</b>	<b>219</b>	<b>137 PS</b>	
<i>16</i>		<b>4578338</b>	<b>3/86</b>	<b>Gruber et al.</b>	<b>430</b>	<b>120</b>	
<i>16</i>		<b>4810612</b>	<b>3/89</b>	<b>Ueda et al.</b>	<b>430</b>	<b>109</b>	
<i>16</i>		<b>4921771</b>	<b>5/90</b>	<b>Tomono et al.</b>	<b>430</b>	<b>110</b>	
<i>16</i>		<b>4988598</b>	<b>1/91</b>	<b>Tomono et al.</b>	<b>430</b>	<b>99</b>	
<i>16</i>		<b>4990424</b>	<b>2/91</b>	<b>Van Dusen et al.</b>	<b>430</b>	<b>106.6</b>	
<i>16</i>		<b>5741617</b>	<b>4/98</b>	<b>Inaba et al.</b>	<b>430</b>	<b>110</b>	
<i>16</i>		<b>6002903</b>	<b>12/99</b>	<b>Hayase et al.</b>	<b>399</b>	<b>279</b>	
<i>16</i>		<b>6458502B1</b>	<b>10/02</b>	<b>Nakamura et al.</b>	<b>430</b>	<b>137.17</b>	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
<i>16</i>	<b>JP</b>	<b>52-3304</b>	<b>1/77</b>	<b>Japan</b>			<b>Abstract and USP 4988598</b>
<i>16</i>	<b>JP</b>	<b>52-3305</b>	<b>1/77</b>	<b>Japan</b>			<b>Abstract and USP 4921771</b>
<i>16</i>	<b>JP</b>	<b>56-13945</b>	<b>4/81</b>	<b>Japan</b>			<b>Abstract</b>
<i>16</i>	<b>JP</b>	<b>57-52574</b>	<b>3/82</b>	<b>Japan</b>			<b>Abstract and USP 4301355</b>
<i>16</i>	<b>JP</b>	<b>60-217366</b>	<b>10/85</b>	<b>Japan</b>			<b>Abstract</b>
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER <i>J Goodrow</i>				DATE CONSIDERED <i>7/05</i>			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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				APPLICANT <b>TATSUYA NAKAMURA ET AL.</b>			
				FILING DATE <b>December 4, 2003</b>		GROUP <b>Unassigned</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
16	JP	60-252360	12/85	Japan			Abstract
16	JP	60-252361	12/85	Japan			Abstract
16	JP	61-94062	5/86	Japan			Abstract and USP 4578338
16	JP	61-138209	6/86	Japan			Abstract and USP 4810612
16	JP	61-273554	12/86	Japan			Abstract
16	JP	62-14166	1/87	Japan			Abstract
16	JP	1-109359	4/89	Japan			Abstract
16	JP	2-79860	3/90	Japan			Abstract and USP 4990424
16	JP	3-50559	3/91	Japan			Abstract
16	JP	5-341573	12/93	Japan			Abstract
16	JP	10-20548	1/98	Japan			Abstract
16	JP	11-202553	7/99	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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